3M™ Wiremount Sockets, CHG Series

0.100" x 0.100" (2.54mm x 2.54mm)

Product Specification 78-5102-0010-0

Released: 4-1-22



1. Scope

This document summarizes test methods, test conditions and product performance requirements for the 3M™ Wiremount Socket, CHG Series with 30μ " gold plating. Listings of materials, finishes, test conditions, and test standards are included in this specification. In the event of conflict between this specification and any documents listed below, the listed documentation supersedes this specification.

2. 3M Documents

78-5100-0189-0	Technical Data Sheet, 3M™ Wiremount Socket .100" x .100", CHG-10XX-001010-KXX, CHG Series
78-5100-0191-6	Technical Data Sheet, 3M™ Wiremount Socket CHG-20XX-001010-KXX CHG Series
78-5100-0192-4	Technical Data Sheet, 3M™ Pak 100 Plarized Wiremount Socket, CHG Series
34-7021-1570-0	Assembly Instructions, 3M™ Wiremount Socket Connector 3739-CHGA
	Instructions for Notched Flat Cable
3624-41	Assembly Instructions, 3M™ Assembly Heads 3624-41 and 3624-42
3624-42	Instructions for discrete wire
3586-12	Manual Pistol Grip 3586-12

3. Performance and Test Description

Unless otherwise specified, all tests shall be performed on 3M™ Pak 100 Polarized Wiremount Socket, CHG Series sockets mated to 3M™ Four-Wall Header, 3000 Series or 3M™ Wiremount Socket CHG-20XX-001010-KXX CHG Series mated to 3M™ Pin Strip Header, 929 Series 0.235" to 0.318" lengths. Cable must be tinned 22, 24, 26, and 28 AWG; solid or stranded wire. Unless otherwise specified, all values and limits are typical of those obtained by qualification testing of the subject product. All specifications are subject to revision and change without notice from 3M.

4. Requirements Overview

4.1 Ratings

Dielectric Withstanding Voltage: 500 VAC_{RMS} at sea level

Temperature: -55°C to +105°C

Insulation resistance: >1 $\times 10^{9} \Omega$ at 500 VDC

Current: (EIA-364-070 method 2, 30°C maximum temperature rise.)

	AWG				
	22	24	26	28	Units
1 Contact Powered	4.50	3.75	3.50	3.50	
4* Contacts Powered	3.00	2.50	2.00	2.00	Amperes
All Contacts Powered	1.50	1.25	1.00	1.00	

*Lines are adjacent in 2x2 configuration

4.2 Materials

Socket

Insulation: Glass Filled PBT Flammability: UL 94V-0 IDC Contact: Copper Alloy

4.3 Finishes

Plating:

Nickel (second wipe, U-Slot, underplate): 50 - 150 μ inches (1.27 - 3.81 μm), ASTM B689-97, SAE AMS-QQ-N-290 Gold (first wiping area): 30 μ inches (0.76 μm) Avg, MIL-G-45204 Type II, Grade C

4.4 Cable Accommodation

General Accommodation:

Tinned 22, 24, 26, 28 AWG stranded or solid conductor .050" (1.27mm) pitch notched flat ribbon cable or discrete wire PVC, FEP, or TPE insulation.

4.5 Regulatory Compliance

For regulatory information about this product, visit 3M.com/regs or contact your 3M representative.

5. Electrical

Description or Parameter	-		Units	Requirement or Conditions	Test Standard or Method			
Dielectric Withstanding Voltage	1000		VAC _{RMS}	Measured between adjacent and opposing contacts. No disruptive discharge during 1 minute duration. Sea level with 70% relative humidity. Excludes cable.	EIA-364-20F Method B Test Condition I			
Dielectric Breakdown Voltage	1000		1000		VAC/sec	Ramp assembled pair at 500V/s until electrical arc. Sea level with 70% relative humidity. Excludes cable.	EIA-364-20F Method B Test Condition I	
Insulation Resistance	>1x10 ⁹		Ohms	Mated connectors. Measured between adjacent and opposing contacts. 500 VDC for 1 minute duration.	EIA-364-21F			
	22 AWG	24 AWG		Tested with: Sockt Part Number: CHG-2060-01010-KEP Header Part Number: 2560-6002-UG				
	4.00	3.75		1 line energized. 30°C temp. rise. 20% derated.				
Temperature Rise (Current Rating)	3.00	2.50		4 lines (2x2) energized. 30°C temp. rise. 20% derated.				
	1.50	1.25	Amperes	All lines energized. 30°C temp. rise. 20% derated.	EIA-364-70A,			
	26 AWG	28 AWG		Tested with: Sockt Part Number: CHG-2060-01010-KCP Header Part Number: 2560-6002-UG	Method 2			
	3.50	3.50		1 line energized. 30°C temp. rise. 20% derated.	1			
	2.00	2.00		4 lines (2x2) energized. 30°C temp. rise. 20% derated.]			
	1.00	1.00		All lines energized. 30°C temp. rise. 20% derated.				
Low Level Connection Resistance	ction <10 Milliohm		Milliohms	10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-23C			

6. Mechanical

Description or Parameter	Values & Limits	Units	Units Requirement or Conditions		
Vibration	50-2000 5.35	Hz g	1.5 hours X, Y, & Z axis. Mated connector shall exhibit no discontinuities greater than 10 ns and 10 milliohm maximum ∆R contact resistance throughout testing.	Condition V, Table 2	
Mechanical Shock	50	g	3 Shocks each directions for X, Y, & Z axis. 18 total. Mated connector shall exhibit no discontinuities greater than 10 ns and 10 milliohm maximum ΔR contact resistance throughout testing.	EIA-364-27B Test Cond. C	
Mating Force / Contact	200 max avg	g	Mated to a .025" square pin. Average for connector. (Insertion Force)	EIA-364-13E Method A	
Unmating Force / Contact	35 min avg	g	Mated to a .025" square pin. Average for connector. (Withdrawl Force)	EIA-364-13E Method A	
Durability (with Environmental)	50 (30 μ")	Mating cycles	10 milliohm maximum $\triangle R$ contact resistance per mated interface throughout testing.	EIA-364-09C	

7. Physical

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Description or Parameter	Values & Limits	Units	Units Requirement or Conditions			
Visual	NA	NA	No defects such as deformation, blister, damage, crack, etc.	EIA-364-18A		
(Metallic Coating) Adhesion	NA	NA	No cracking, flaking.	MIL-G-45204 Section 4.6.2		
Plating thickness Nickel Gold	50-150 30 Avg	μ"	Average of random measurements from any 3 lots.	EIA-364-48		

8. Environmental

Description or Parameter	Values & Limits	Units	Requirement or Conditions	Test Standard or Method
Temperature Life	250 105	hours °C	No physical abnormalities . 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-17C Method A Condition 4
Humidity Temperature Cycling	10 +25 to +65 80 to 100 -10	Days °C % RH °C	-10C subcycle. No physical abnormalities. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-31F Method IV Fig 1
Thermal Shock	-55 to +105 5	°C cycles	No physical abnormalities. 10 milliohm maximum ∆R contact resistance per mated interface throughout testing.	EIA-364-32G Method A, Test Cond. VII
Salt Spray	Salt Spray 5 % NaCl 48 hours		10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-26C Test Cond. B

9. Test Sequence

9.1 Sequenced Tests

TEST FLOW

TEST	EIA 364	TEST GROUP & TEST SEQUENCE				E	
IESI	TP NO.	Α	В	С	D	Е	F
Visual	18	0,8	0,4	0,6	0,6	0,6	0,3
LLCR	23	1,3,5,7	1,3	1,3,5	1,3,5		
Durability (Full)	13	2			2	3	
Temperature Life (Full)	17		2				
Mechanical Shock	27			2			
Vibration	28			4			
Thermal Shock	32	4					
Humidity Temperature Cycling	31	6					
Salt Spray	26				4		
Dielectric Withstanding Voltage	20					1,4	2
Dielectric Breakdown Voltage	20					7	
Insulation Resistance	21					2,5	
Temperature Rise vs. Current	70						1

9.2 Independent Tests

- 1. Mating & Unmating Force
- 2. (Metal Coating) Adhesion

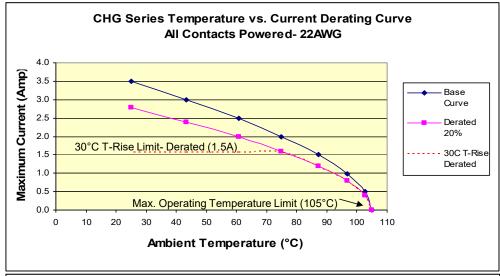
10. Agency Listings

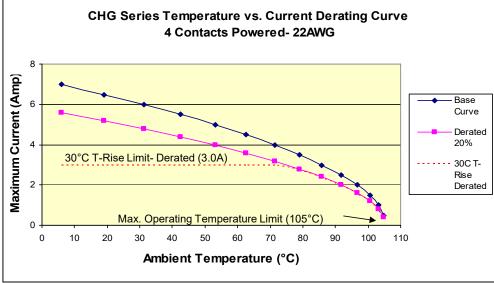
10.1 Underwriters Laboratories (UL)

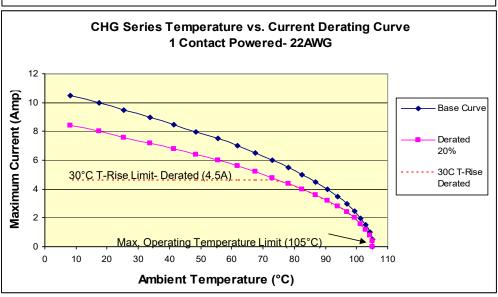
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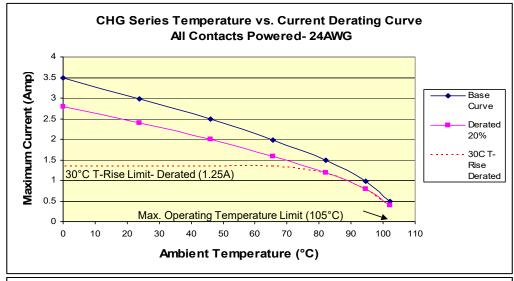
11.0 Figures

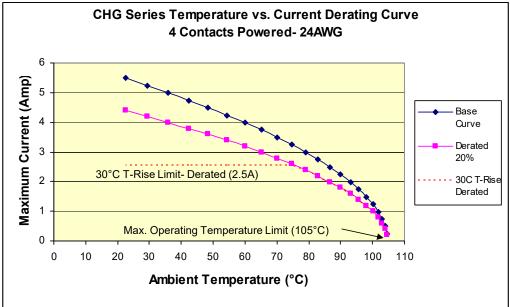
11.1 Temperature Rise vs. Current

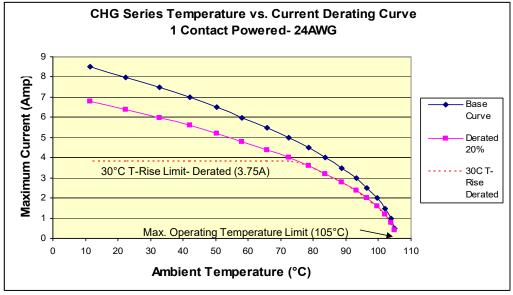


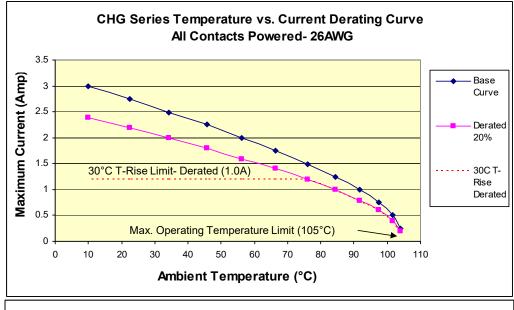


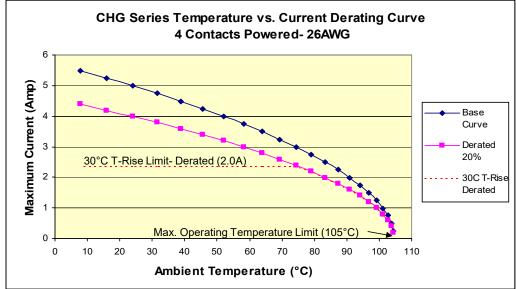


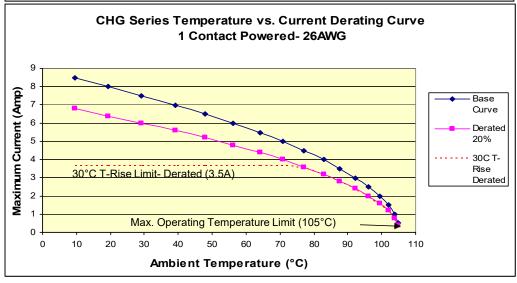


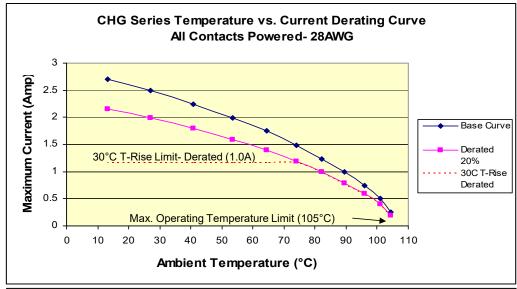


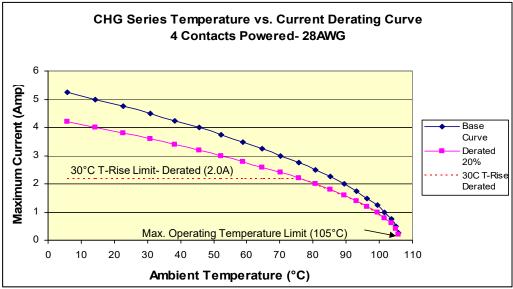


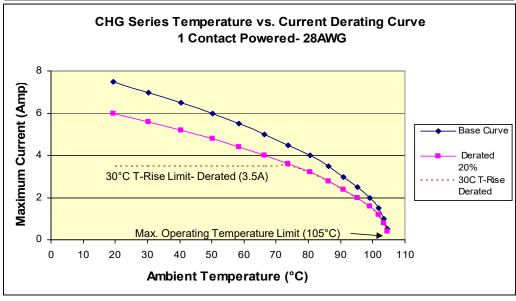












Unless otherwise noted, references to industry specifications are intended to indicate substantial compliance to the material elements of the specification. Such references should not be construed as a guarantee of compliance to all requirements in a given specification.

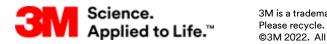
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